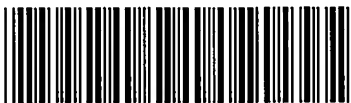


**Search Notes**

Application/Control No.

10/606,258

Examiner

Usmaan Saeed

Applicant(s)/Patent under  
Reexamination

CHIN ET AL.

Art Unit

2166

**SEARCHED**

Class	Subclass	Date	Examiner
707	104.1	2/13/2006	US
716	18	2/13/2006	US

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor & related case search	3/9/2006	US
East (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB)	2/13/2006	US
Plus	2/13/2006	US
Consulted Primary Examiner (Khanh Pham)	3/9/2006	US
Consulted Primary Examiner (Leslie Wong)	2/13/2006	US